DEC 1 0 2004

SHEET 1 OF 1

Form PTO 1448	***************************************	U.S. DEPARTMENT	F COMMERCE	ATTY DOCKET NO.		SERIAL N	10.	
(Modified)		PATENT ANTONO	MARK OFFICE	237688US0		10/617,	D48	·
				APPLICANT		· · · · · · · · · · · · · · · · · · ·		
LISTOF	REFER	RENCES CITED BY APP	LICANT	Terry V. LIEW, et al.				
				FILING DATE		GROUP		
				July 11, 2003		1711		
				U.S. PATENT DOCUMENTS				
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB	Fil	JNG DATE
INITIAL		NUMBER			70.00	CLASS	IF AF	PROPRIATE
The state of the s	AA	2002/0051758 A1	05/02/2002	Heng CAI, et al.				
M	AB	6,051,216	04/18/2000	Morton L. BARR, et al.			•	
	AC	2002/0028223 A1	03/07/2002	Michael Lee VATTER, et al.				
	AD	····						
	AE							
	AF							
	AG AU							
	AH							
	Al .							
	AJ							
	AK				·			
	AL							
	AM				ļ			
	AN		<u> </u>		<u> </u>	<u>.                                    </u>	L	
			FO	REIGN PATENT DOCUMENTS				
		DOCUMENT	DATE	COLINERY			TRANS	LATION
		NUMBER	DATE	COUNTRY		YE	<u>s</u>	NO
ap	AO	1 266 648	12/18/2002	EUROPE				<u> </u>
.9	AP							
	AQ							
	AR							
	AS						I	
	AT							
	AU							
	AV			·		L		
		OTHER RI	FERENCES	(Including Author, Title, Date, Pertinen	t Pages, e	etc.)		
	1							
	AW	·						
	<del>                                     </del>		<del></del>					
	AX							
	AY							
<b> </b>	╂	/			T		· · · · · · · · · · · · · · · · · · ·	
	AZ	011/					_/_	s)teet(s) attached
Examiner	بر	11 Wan	1		Date Co	nsidered	41	2005
*Examiner_li	nitial if	reference is considered ot considered. Include,	whether or no opy of this for	ot citation is in conformance with MPEP 6 on with next communication to applicant.	09; Draw	ine throug	n citation	if not in

7/2007

SHEET 1 OF 1

			1000					
Form PTO 1449		U.S. DEPARTMENT PATENT AND TRA	DE COMMERCE	ATTY DOCKET NO.		SERIAL I	ΝΟ.	
(Modified)		PATENT AND TRAD	A A A A A A A A A A A A A A A A A A A	237688US0		10/617,	048	
				APPLICANT				
LIST OF	REFEF	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.			•	
`				FILING DATE		GROUP		
				July 11, 2003		1711		
		-		U.S. PATENT DOCUMENTS	-			
EVAMINED		2001115117	ή	I DOGGINENTO	γ			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS		ILING DATE PPROPRIATE
	AA		· · · · · · · · · · · · · · · · · · ·		<del>  -</del>	02.00		
	AB	<del></del>	<del> </del>					
	AC		<del> </del>				•	<del>,</del>
			, , , , , , , , , , , , , , , , , , , ,		<b></b>			
	AD.				ļ			
	AE		ļ					
	AF				<u> </u>			
	AG				1			
	AH							
	Al				1			
	AJ				1			
	AK		1		<del>†</del>			-
	AL		<del>                                     </del>		†			
	AM		<del></del>		<del></del>			
	AN	•	<del>                                     </del>		<del> </del>	<del> </del>		
ll .	~I*	1						
				<u> </u>		٠	L	<del></del>
			FO	PREIGN PATENT DOCUMENTS	<del></del>			
		DOCUMENT	T	T		· · · · · · · · · · · · · · · · · · ·	TRANS	SLATION
1/		DOCUMENT NUMBER	DATE	COUNTRY				SLATION NO
	AO		T	T		YE		SLATION NO
	AO AP	NUMBER	DATE	COUNTRY				
	AP	NUMBER	DATE	COUNTRY				
	AP AQ	NUMBER	DATE 12/25/02	COUNTRY				
	AP AQ AR	NUMBER	DATE 12/25/02	COUNTRY			S	
	AP AQ AR AS	NUMBER	DATE 12/25/02	COUNTRY				
	AP AQ AR AS AT	NUMBER	DATE 12/25/02	COUNTRY			S	
	AP AQ AR AS AT AU	NUMBER	DATE 12/25/02	COUNTRY			S	
	AP AQ AR AS AT	NUMBER	DATE 12/25/02	COUNTRY			S	
	AP AQ AR AS AT AU	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY		YE	S	
	AP AQ AR AS AT AU AV	NUMBER 1386489	DATE 12/25/02	COUNTRY	nt Pages, e	YE:	5	NO
	AP AQ AR AS AT AU AV  AW AX	NUMBER 1386489	DATE 12/25/02	COUNTRY	nt Pages, e	YE:	5	
Examiner	AP AQ AR AS AT AU AV  AW AX	NUMBER 1386489	DATE 12/25/02	COUNTRY	nt Pages, e	YE:	5	NO
*Examiner: In	AP AQ AR AS AT AU AV  AW AX AY	NUMBER 1386489  OTHER R	DATE 12/25/02  EFERENCES	COUNTRY	Add	YE:	erences	sheet(s) attached

Nov. 28, 2005

SHEET 1 OF 5

Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL N	10.
(Modified)		PATENT AND TRAD	EMARK OFFICE	237688US0		10/617,	048
		·		APPLICANT			
LIST OF	REFER	RENCES CITED BY API	PLICANT	Terry V. LIEW, et al.			
				FILING DATE		GROUP	
				July 11, 2003		1711	
				U.S. PATENT DOCUMENTS	•	•	
EXAMINER		DOCUMENT ·	DATE	NAME	CLASS	SUB	FILING DATE
INITIAL	<u> </u>	NUMBER			OLAGG	CLASS	IF APPROPRIATE
<u> </u>		2,823,195		Shorr, et al.			
<u> </u>		3,723,566	03/27/73	Thompson, et al.			
<u> </u>		4,322,400	03/30/82	E. Yuhas			
		5,262,505	11/16/93	Nakashima, et al.			
<u> </u>		5,407,986		Furukawa, et al.			
		5,412,004	05/02/95	Tachibana, et al.			
		5,473,041	12/05/95	M. Itoh			
		5,567,428	10/22/96	K. Hughes			·
		5,725,882	1	Kuman, et al.			
	AJ	5,837,223	11/17/98	Barone, et al.			
	AK	5,874,069	02/23/99	Mendolia, et al.			
	AL	5,919,441	07/06/99	Mendolia, et al.			
7	AM	5,981,680	11/09/99	Petroff, et al.			
W	AN	5,985,297	11/16/99	Mellul, et al.			
		<u> </u>	FO	REIGN PATENT DOCUMENTS	·		-
		DOCUMENT				T	TRANSI ATION
		NUMBER	DATE	COUNTRY		YES	TRANSLATION
V	AO	GB 134 8783	03/20/74	London		X	, 140
	AP	EP 0 377 447 A2	07/11/90	EPO	<del>* </del>	×	
		EP 0 693 517 A1		EPO		×	· ·
		WO 97/36572	10/09/97	WIPO	·-	×	
		WO 97/36573	10/09/97	WIPO		×	<del></del>
		FR 2 765 800		France (English Abstract Provided)	<del></del>		- X
<del></del>		WO 99/47111	01/15/99	WIPO		<u> </u>	X
1./		WO 99/06473		WIPO		×	
100		L	<u> </u>	L		L	
				Including Author, Title, Date, Pertinent			
A	AW	Dow Coming@ 2-81	/8 Gellant, I	Ref. No. 27-1055-01, August 2002, 3	55 pp.		,
	AX	Dow Corning® 2-81	78 Gellant, F	Product Information Personal Care, 6	pp., 8/1	3/02	
		Shin-Etsu Silicones 1 Powders for Persona		Care; Product Brochure, KSP-100-10	01-102-10	03-104-10	5 "Hybrid Silicone
				Care; Product Brochure, KSP-			
1			cone Powde	rs containing Fluoroalkyl or Phenyl	Addi	tional Refe	rences sheet(s) attached
Examiner					Date Cor		Must
*Examiner: Ir conformance	and no	eference is considered, of considered. Include co	whether or no ppy of this form	t citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw li	ne through	citation if not in

Form PTO 1449		U.S. DEPARTMENT				SERIAL N	10.
(Modified)		PATENT AND TRAC	EMARK OFFICE	237688US0		10/617,	048
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.			
				FILING DATE		GROUP	
				July 11, 2003		1711	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL	/	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
1	AA	6,045,782	04/04/00	Krog, et al.			
	AB	6,051,216	04/18/00	Barr, et al.			
	AC	6,060,072	05/09/00	Konik, et al.			
	AD	6,103,250	08/15/00	Brieva, et al.			
	ΑE	6,353,076 B1	03/05/02	Barr, et al.			
	AF	6,362,287	03/26/02	Chorvath, et al.			
	AG	6,362,288	03/26/02	Brewer, et al.			
	AH	6,423,324	07/23/02	Murphy, et al.			*
	Al	6,426,062	07/30/02	Chopra, et al.			,
	AJ	6,451,295 B1	09/17/02	Cai, et al.			
	AK	6,541,017	04/01/03	Lemann, et al.	·		
	AL	6,503,632 B1	01/07/03	Hayashi, et al.			
	AM	6,524,598	02/25/03	Sunkel, et al.			
AV	AN	6,569,955 B1	05/27/03	Brewer, et al.			
7.			FO	REIGN PATENT DOCUMENTS	*	·	
. 1		DOCUMENT					TRANSLATION
	_	NUMBER	DATE	COUNTRY		YES	TRANSLATION · NO
	AO	EP 0 923 928	06/23/99	EPO (English Abstract Provided)			x .
<i>7' T</i>	AP	EP 1 048 686	11/02/00	EPO		Х	
	AQ	EP 1 068 856	01/17/01	EPO (English Abstract Provided)			x
$\perp I$	AR	WO 01/09239 A1	02/08/01	WIPO		х	
	AS	WO 01/97758 A2	12/27/01	WIPO		х	
	AT	WO 02/17870 A2	03/07/02	WIPO		Х	
	AU	WO 02/17871 A2	03/07/02	WIPO		х	
	AV	WO 02/089760 A1	11/14/02	WIPO		Х	
71.		OTHER RE	FERENCES (	Including Author, Title, Date, Pertinent	Pages, e	tc.)	
K	AW	English Language Der	went Abstract	of EP 0 923 928, June 23, 1999			
//	AX	English Language Der	went Abstract	of EP 1 068 856, January 17, 2001	··. <u>.</u>		
D	AY	English Language Der	went Abstract	of FR 2 765 800, January 15, 1999			
7	AZ	11/1			Addi	tional Refe	rences sheet(s) attached
Examiner	-/	1/1/1/	/		Date Considered 7/2004		
*Examiner: In conformance	and no	eference is considered, ot considered. Include co	whether or no ppy of this form	t citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lir	ne through	citation if not in

Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL N	10.			
(Modified)		PATENT AND TRAD	EMARK OFFICE	237688US0 10/617,048						
				APPLICANT		·				
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.						
				FILING DATE		GROUP				
				July 11, 2003		1711				
				U.S. PATENT DOCUMENTS						
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB	FILING DATE			
INITIAL		NUMBER			CLASS	CLASS	IF APPROPRIATE.			
$-\mathcal{H}_{1-}$		2002/0048557 A1	04/25/02	Cai, et al.						
-  -		2003/0068348	04/10/03	Ferrari, et al.						
<b></b>		2003/0072730	04/17/03	Tournilhac						
		2003/0082129 A1	<del> </del>	Buckingham, et al.						
		2003/0170188	09/11/03	Ferrari, et al.						
	AF	2003/0232030 A1	12/18/03	Lu, et al.						
		2003/0235548 A1		Lu, et al.						
· ·	AH	2003/0235552	12/25/03	Yu, W.						
	Al	2003/0235553 A1	12/25/03	Lu, et al.						
	AJ	2004/0001799 A1	01/01/04	Lu, et al.						
	AK	2004/0115153 A1	06/17/04	W. Yu						
	ÁL	2004/0115154 A1	06/17/04	W. Yu						
11/	AM	2004/0120912 A1	06/24/04	W. Yu						
	AN	2004/0126336 A1	07/01/04	Hansenne, et al.						
$\mathcal{P}$			FO	REIGN PATENT DOCUMENTS		<u> </u>	•			
		DOCUMENT				· .				
		NUMBER	DATE	COUNTRY		YES	TRANSLATION			
	AO	WO 03/013447 A2	02/20/03	WIPO		X	NO NO			
1	AP	WO 03/105788 A2	06/02/03	WIPO		X				
	AQ	EP 1 266 647		EPO (English Abstract Provided)		^	×			
		EP 0 594 285 A2	<del></del>	EPO		· x				
<del>                                      </del>		WO 2004/054523	07/01/04	WIPO		×				
<del></del>	AT	WO 2004/054524	07/01/04	WIPO		×				
<i> </i>	AU	WO 01/97758 A2	12/27/01	WIPO		×				
1/		EP 1 266 648		EPO (English Abstract Provided)			<del></del>			
							X			
		OTHER RE	FERENCES (	Including Author, Title, Date, Pertinent	Pages, e	tc.) 				
	AW									
	AX			•						
					· · · · · ·					
	AY									
	AZ	M,			∏ Δddi	tional Pofe	rences sheet(s) attached			
Examiner			/				and a literal strategy attached			
<u> </u>	المدر <sub>ا - اد</sub>				Date Cor		1/401			
conformance	and no	ererence is considered, of considered. Include co	whether or not ppy of this form	citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw li	ne through	citation if not in			

Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL I	NO.
(Modified)		PATENT AND TRAC	DEMARK OFFICE	237688US0		10/617,	048
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.			·
				FILING DATE		GROUP	
				July 11, 2003		1711	
				U.S. PATENT DOCUMENTS			
EXAMINER INJTIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
1	ĀĀ	2004/0170586 A1	09/02/04	Ferrari, et al.			
	AB	2004/0180032 A1	09/16/04	Manelski, et al.			
	AC	2005/0020769 A1	01/27/05	Lu, et al.			
	AD	2005/0009989 A1	01/13/05	Liew, et al.			
	AE	2005/0089492 A1	04/28/05	Lu, et al.		-	
	AF	6,916,464 B2	07/12/05	Hansenne, et al.			
	AG	2005/0158260 A1	07/21/05	Ferrari, et al.			
	AH	5,969,172	10/19/99	Susan A. Nye			
	Al	2002/0051758	05/02/02	Cai, et al.			
	AJ	4,822,852	04/18/89	Wittmann, et al.			
	AK	2,823,218	02/11/58	Speier, et al.			
	AL	2003/0228333	12/11/03	Fecht, et al.			
4/	AM	2004/0197285	10/07/04	Heidi Marie Van Dort			
	AN	2004/0223936 A1	11/11/04	Fecht, et al.			·
11			FO	REIGN PATENT DOCUMENTS	1		•
			1	I			
1		DOCUMENT NUMBER	DATE	COUNTRY		YES	TRANSLATION NO
	AO	WO 03/101412 A2	12/11/03	WIPO		Х	
_//	AP						
	AQ		<u></u>				
	AR						
	AS		ļ				
	AT	<u> </u>					
	AU						
	AV		<u> </u>				
		OTHER RE	FERENCES (	Including Author, Title, Date, Pertinent	l Pages, e	tc.)	
	AW						
	4.7		•				
	AX						
	AY						
	AZ	11/1			Addi	tional Refe	rences sheet(s) attached
Examiner		11/1/		,	Date Cor	nsidered	Thank
*Examiner: In conformatice	itial if r	eference is considered, of considered. Include co	whether or not opy of this form	t citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lir	ne through	citation of not in

LIST OF REFERENCES CITED BY APPLICANT  LIST OF REFERENCES CITED BY APPLICANT  Terry V. LIEW, et al.  FILING DATE July 11, 2003  TOUMENT  U.S. PATENT DOCUMENTS  EXAMINER AA 2002/0028223 A1 03-07-02 Michael Lee Vatter, et al.  AA 2002/0028223 A1 03-07-02 Michael Lee Vatter, et al.  AC 6,177,091 01/23/01 I. Bara, et al.  AE	Form PTO 1449		U.S. DEPARTMENT ( PATENT AND TRAD	OF COMMERCE	ATTY DOCKET NO.			SERIAL NO. 10/617 048		
UST OF REFERENCES CITED BY APPLICANT   Terry V. LIEW, et al.   FILING DATE   July 11, 2003   1711   1, 2003   1711   1, 2003   1711   1, 2003   1711   1, 2003   1711   1, 2003   1711   1, 2003   1, 2005	(Modified)		PATENT AND TRAD	EMARK OFFICE	237688US0	10/617,048				
FILING DATE   July 11, 2003   1711				•	APPLICANT					
July 11, 2003   1711	LIST OF	REFEI	RENCES CITED BY API	PLICANT	Terry V. LIEW, et al.					
S. PATENT DOCUMENTS					FILING DATE		GROUP			
DOCUMENT NUMBER   NAME   CLASS   SUB   FILING DATE					July 11, 2003		1711		•	
NUMBER					U.S. PATENT DOCUMENTS					
NUMBER   SAPERIOR			DOCUMENT	DATE	NAME	CLASS		FI	LING DATE	
AG 6,376,078	INITIAL					CLASS	CLASS	IF A	PPROPRIATE	
AC 6,177,091 01/23/01 I. Bara, et al.	1/1/		·							
AE				1						
AE		AC	6,177,091	01/23/01	I. Bara, et al.					
AF		AD								
AG		AE			·					
AH		AF								
AI		AG								
AJ		АН								
AK		Ai								
AL		AJ								
AM	•	AK								
AN		AL								
DOCUMENT   DATE   COUNTRY   TRANSLATION   YES   NO		AM								
DOCUMENT NUMBER   DATE   COUNTRY   TRANSLATION YES   NO		AN	-							
DOCUMENT NUMBER   DATE   COUNTRY   TRANSLATION YES   NO			<del>* · </del>	FO	REIGN PATENT DOCUMENTS	<del></del>	L		<del> </del>	
NUMBER   DATE   COUNTRY   YES   NO	<u> </u>	r	2001115115	T	1		<u> </u>			
AO				DATE	COUNTRY					
AP		AO					1 = 3	<u> </u>	NO	
AQ	ļ								_	
AR										
AS AT AT AU AU AV AX				<del>                                     </del>						
AT AU AU AV OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)  AW AX		<u> </u>							·	
AU				<del>                                     </del>						
AV OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)  AW  AX  AY  AZ  Date Considered T MMT				ļ	· · · · · · · · · · · · · · · · · · ·	•				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)  AW  AX  AY  AZ  Date Considered T MMT				<del>                                     </del>	<del> </del>					
AW  AX  AY  AZ  AZ  AZ  AZ  Additional References sheet(s) attached  Examiner  Date Considered T NWY			OTHER DE	EEDENASA :						
AX  AY  AZ  AZ  AZ  AZ  Additional References sheet(s) attached  Examiner  Date Considered T NWY			OTHER RE	FERENCES (	including Author, Title, Date, Pertinen	t Pages, et			· · · · · · · · · · · · · · · · · · ·	
AZ Additional References sheet(s) attached  Examiner Date Considered Think		AW								
AZ Additional References sheet(s) attached  Examiner Date Considered 7 2007		AX							_	
Examiner Date Considered 7 2007		AY								
Examiner Date Considered 7/2007		AZ	MI	/		Addi	tional Refe	rences s	sheet(s) attached	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	Examiner		1///	1		<del>                                     </del>	· · · · · ·	71	2002	
	*Examiner: In conformance	itial if r	eference is considered, of considered, Include co	whether or no	t citation is in conformance with MPEP 60 with next communication to applicant.	09; Draw lir	ne through	citation	if not in	

				/			•
Form PTO 1449		U.S. DEPARTMENT PATENT AND TRAD	FOOTH ENCE	ATTY DOCKET NO.		SERIAL NO	). /1.11
(Modified)		PATENT AND TRAD	EMARK OFFICE	275576US0		11/103,4	44 /0/4/1
				APPLICANT			
LIST OF	REFE	RENCES CITED BY APP	PLICANT	Michell CHEN, et al.			,
				FILING DATE		GROUP	
				August 1, 2005		1615	
				U.S. PATENT DOCUMENTS	<del>.</del>	L <u></u>	
EXAMINER		DOCUMENT	DATE	NIAME	GI 400	SUB	FILING DATE
INITIAL		NUMBER	DATE	NAME	CLASS	CLASS	IF APPROPRIATE
X	AA	2,823,195	02/11/58	Shorr, et al.			
	AB	3,723,566	03/27/73	Thompson, et al.			
	AC	4,322,400	03/30/82	E. Yuhas			
	AD	5,262,505	11/16/93	Nakashima, et al.			
	\AE	5,407,986	04/18/95	Furukawa, et al.			
	AF	5,412,004	05/02/95	Tachibana, et al.			
	AG	5,473,041	12/05/95	M. Itoh			
	AH	5,667,428	10/22/96	K. Hughes			
	Al	5,726,882		Kuman, et al.			
		5,837,223		Barone, et al.		<del></del>	
		5,874,069		Mendolia, et al.		<del></del>	
-		5,919,441		Mendolia, et/al.			
		5,981,680		Petroff, eval.	<u> </u>		<del></del>
<del></del>		5,985,297		Mellul et al.			
		,,,,,,,,,		<u> </u>	L	l	
			FO	REIGN PATENT DOCUMENTS			
		DOCUMENT NUMBER	DATE	COUNTRY		. т	RANSLATION
						YES	NO
		GB 134 8783	-	London		X	
		EP 0 377 447 A2		ЕРО		×	
			<b>/</b>	Peo		X	
		WO 97/36572		wiko		X	
ļ		WO 97/36573		WIPO		X	
				France (English Abstract Provided)			X
				WIPO			X
	AV	WO 99/06473	02/11/99	WIPO \		· <b>X</b>	
		OTHER RE	FERENCES (	Including Author, Ville, Date, Pertinent	Pages, e	tc.)	
1	AW	Dow Corning® 2-81	78 Gellant, R	Ref. No. 27-1055-01, August 2002, 3	55 pp.		
	AX	Dow Corning® 2-81	78 Gellant, P	roduct Information Personal Care, 6	pp., 8/1	3/02	
		Ohio Pro Oili o	. D				
	AT	Powders for Personal	Care" 2000		01-102-10	)3·104·105	"Hybrid Silicone
	AZ	Shin-Etsu Silicones 200-300 "Hybrid Sili group for Personal Ca	cone Powder	Care; Product Brochure, KSP- rs containing Fluoroalkyl or Phenyl	Addi	tional Refere	ences sheet(s) attached
Examiner	7	// 1/1/			Date Cor	nsidered	2/2 2
*Examiner: In conformance	itia if ro	eference is considered, of considered. Include co	whether or not py of this form	citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lii	ne through c	itation if not in

duplicate

		/ Mo.					
Form PTO 1449		U.S. DEPARTMENT PATENT AND THE	OF COMPERCE	ATTY DOCKET NO.		SERIAL N	vo ////
(Modified)		PATENT ARE THE	OFFICE	275576US0	· .	11/193,	10/6/7,04
				APPLICANT			7
LIST OF	REFE	RENCES CITED BY AF	PLICANT	Michell CHEN, et al.			
				FILING DATE		GROUP	
				August 1, 2005		1615	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	6,045,782	04/04/00	Krog, et al.			
	AB	6,051,216	04/18/00	Barr, et al.			
	AC	6,060,072	05/09/00	Konik, et al.			
	AD	6,103,250	08/15/00	Brieva, et al.	1		·
	AE	6,353,076 BI	03/05/02	Barr, et al.	<del>                                     </del>		
	AF	6,362,287	03/26/02	Chorvath, et al.			
		6,362,288	· <del>\</del>	Brewer, et al.			
		6,423,324	1	Murphy, et al.	1		
		6,426,062	07/30/02	Chopra, et al.	<del>/                                    </del>		
	AJ	6,451,295 B1	09/17/08	Cai, et al.		·	
	AK	6,541,017		Lemann, et al.			
		6,503,632 B1	01/07/03	Hayashi, et al.	-		
	_	6,524,598	02/25/03	Sunkel, et al.	+		
		6,569,955 B1		Brewer, et al.	<b>†</b>		
			<del>'                                    </del>	REIGN PATENT DOCUMENTS	<u> </u>	11	
		DOCUMENT	Ţ			I	TOANIOLATION
		NUMBER	DATE	DOUNTRY		YES	TRANSLATION NO
	AO	EP 0 923 928	06/23/99	EPO (English Abstract Provided)		, , ,	X
-	AP	EP 1 048 686		EPO		×	
	AQ	EP 1 068 856	01/17/01	EPO (English Abstract Provided)			X
		WO 01/09239 A1	02/08/01	WIPO		×	<del>-   - ^  </del>
		WO 01/97758 A2	<del> /</del>	WIPO		×	
· ·		WO 02/17870 AZ	<del></del>	WIPO	<del>/</del>	×	
		WO 02/17871 A2		WIPO	-/-	·	
		WO 02/089760 A1		WIPO	$\overline{}$	×	
	~						
				Including Author, Title, Date, Pertiner	nt Pages, e	<u>ue')</u>	
	AW	English Language De	went Abstract	of EP 0 923 928, June 23, 1999			c
	AX	English Language De	rwent Abstract	of EP 1 068 856, January 17, 2001		<b>─ \</b>	,
	AY	English Language De	went Abstract	of FR 2 765 800, January 15, 1999			
	AZ	11/1			Addi	tional Refe	rences sheet(s) attached
Examiner <sub>.</sub>					Date Cor	nsidered	7/2007
*Examiner: in	itial If T	eference is considered,	whether or not	t citation is in conformance with MPEP 6	09; Draw li	ne through	citation if not in :
viiilaijist	will like	,, whistocicu, ilicidde C	ANA OF REER HOLLE.	i wini next carminancadon lo annicant			. п

diplicate

Form PTO 1449		U.S. DEPARTMENT	OF COMMENDE	ATTY DOCKET NO.		SERIAL NO	0	10/61
(Modified)		PATENT AND TRAD	ENTROYETICE	275576US0		11/193,4	44	10/61
				APPLICANT				
LIST OF	REFE	RENCES CITED BY API	PLICANT	Michell CHEN, et al.				,
			•	FILING DATE		GROUP		
				August 1, 2005		1615		
			1	U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB		IG DATE ROPRIATE
	VAA	2002/0048557 A1	04/25/02	Cai, et al.				
		2003/0068348	04/10/03	Ferrari, et al.				
		2003/0072730	04/17/03	Tournilhac				
		<del>\</del>		Buckingham, et al.				
		2003/01/20188	09/11/03	Ferrari, et al.		<del>                                     </del>		
		2003/0232030 A1		Lu, et al.		<del>                                     </del>		
		2003/0235548 A1		Lu, et al.	<del>                                     </del>	<del>                                     </del>		
		2003/0235552	12/25/03	Yu, W.	ļ .	$\vdash$		_
	Ai	2003/0235553 A1	12/25/03	Lu, et al.				
	AJ	2004/0001799 A1		Lu, et al.		<del>                                     </del>		
		2004/0115153 A1		W. Yu	<del>                                     </del>	<del>                                     </del>		
		2004/0115154 A1	06/17/04	WYu	<del> </del>			
	AM	2004/0120912 A1	06/24/04	W. Yu				· · · · · · · · · · · · · · · · · · ·
		<del> </del>		Hansenne, et al.	<del>                                     </del>	<del>                                     </del>		
			L	REIGN PATENT QOCUMENTS		<u> </u>	· <del>-</del> · · · · · ·	
		DOCUMENT				T	RANSLA"	ron .
		NUMBER	DATE	COUNTRY		YES	1041001	NO
	AO	WQ 03/013447 A2	02/20/03	WIPO		X		
	AP	VO 03/105788 A2	06/02/03	WIPO		X		
	AQ	EP 1 266 647	12/18/02	EPO (English Abstract Provided)				Χ.
	AR	EP 0 594 285 A2	04/27/94	EPO	$\overline{}$	×	· · · · · ·	·
	AS	WO 2004/054523	07/01/04	WIPO		×		Œ.
	AT	WO 2004/054524	07/01/04	WIPO.		X		
	AU	WO 01/97758 A2	12/27/01	WIPO		×		
	AV	EP 1 266 648	12/18/02	EPO (English Abstract Provided)			-	X
		OTHER RE	FERENCES (	including Author, Title, Date, Pertinen	t Pages, e	tc.)		
		1					<del> </del>	
	· AW							
	AX							
	AY							
		M	,		Υ			
<i>i</i> 1	ΑZ		/		Addi	itional Refere	ences she	et(s) attached
ŀ		. / // / /		•				7
Examiner		11/11			Date Co	nsidered	7.1	wo

duplicate

Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL N	10.	1,10
(Modified)		PATENT AND TRAD	EMARK OFFICE	275576US0		11/193	144	10/6/1
				APPLICANT			-	7
LIST OF	REFE	RENCES CITED BY API	PLICANT	Michell CHEN, et al.		•		
				FILING DATE		GROUP		
				August 1, 2005		1615		
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL.		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS		ING DATE PROPRIATE
	AA	2004/0170586 A1	09/02/04	Ferrari, et al.				
	AB	2004/0180032 A1	09/16/04	Manelski, et al.				
	AC	2005/0020769 A1	01/27/05	Lu, et al.				
	AD	2005/0009989 A1	01/13/05	Liew, et al.				
	ΑE	2005/0089492 A1	04/28/05	Lu, et al.				
	AF	6,916,464 B2	07/12/05	Hensenne, et al.				
	AG	2005/0158260 A1	07/21/08	Ferrari, et al.				
	<del></del>	5,969,172	10/19/99	Susan A. Nye	t			
	-	2002/0051758	05/02/02	Cai, et al.				
		4,822,852	04/18/89	Wittmann, et al.	<u> </u>		·····	
		2,823,218	02/11/58	Speier, et al.	<del>                                     </del>		_	
	AL	2093/0228333	12/11/03	Fecht, et al.	<del>                                     </del>			
	AM	2004/0197285	10/07/04	Heidi Marie Van Dort		<del>                                     </del>		
	<del>-/-</del>		10/0//01	ricidi Mario Vali Bott	<u> </u>	<del>                                     </del>		
	L/AN	2004/0223936 A1	11/11/04	Fecht et al	· •	<b>*</b>		
	AN	2004/0223936 A1	11/11/04	Fecht, et al.				
	AN	2004/0223936 A1	·	Fecht, et al. REIGN PATENT DOCUMENTS	l	<b>†</b>		
	AN	DOCUMENT NUMBER	·	<del></del>		YES	TRANSL	ATION NO
	AO	DOCUMENT	FO	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO	DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO AP	DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO AP AQ	DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO AP AQ AR	DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO AP AQ AR AS	DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO AP AQ AR AS	DOCUMENT NUMBER	DATE	COUNTRY		YES		
	AO AP AQ AR AS AT	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO	t Pages e	X		
	AO AP AQ AR AS AT	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY	t Pages, e	X		
	AO AP AQ AR AS AT	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO	t Pages, e	X		
	AO AP AQ AR AS AT AU AV	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO	t Pages, e	X		
	AO AP AQ AR AS AT AU	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO	t Pages, e	X		
	AO AP AQ AR AS AT AU AV	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO	t Pages, e	X		
	AO AP AQ AR AS AT AU AV	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO		YES X		
Examiner	AO AP AQ AR AS AT AU AV	DOCUMENT NUMBER WO 03/101412 A2	DATE 12/11/03	COUNTRY WIPO	Add	YES X		NO

Suplicate

Com 870 1440		ILC DEDARTMENT	T COMMERCE	ATTY DOCKET NO.		SERIAL N	VO /
Form PTO 1449 (Modified)		U.S. DEPARTMENT ( PATENT AND TRAD	EMARK OFFICE	275576US0		11/193	/ / . / . 11/7
	•			APPLICANT		,,,,,,	10/ 11/
LIST OF	REFE	RENCES CITED BY APP	PLICANT	Michell CHEN, et al.			
				FILING DATE		GROUP	
		•		August 1, 2005		1615	
			<del></del>	U.S. PATENT DOCUMENTS		1015	
EVAMINED	Ι	DOCUMENT	· · · · · ·	U.S. PATENT BOCOMENTS	<del></del>	T	
EXAMINER INITIAL (		NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
			03-07-02	Michael Lee Vatter, et al.			
			04723/02	Yoshinori Inokuchi			
	AC	6,177,091	01/23/01	I. Bara, et al.			
·	AD				[		
	AE						
	AF						
	AG				1		
	АН			·	1		
	Al				1 -		
	AJ		····		<del>                                     </del>		
	AK						
· · · · · · · · · · · · · · · · · · ·	AL				<del>                                     </del>		
	AM				-		
	AN	<u> </u>			<del>-  </del>		
	1	I	FO	REIGN PATENT DOCUMENTS		li	
<del></del>	1	DOCUMENT				1	
		NUMBER	DATE	COUNTRY		YES	TRANSLATION NO
	AO						
-	AP						
	AQ			·		·	
	AR			·		Ì	
	AS					<u> </u>	
	AT					<u> </u>	
,	AU					<u> </u>	
	AV					<del> </del>	<del>-   .  </del>
		OTHER RE	FERENCES (	Including Author, Title, Date, Pertine	nt Pages, e	tc.)	
	l		<u>-`</u>				
	AW						
	4						
	AX			•			
	AY	G		•			
	AZ		1/		Addi	tional Refe	erences sheet(s) attached
Examiner		MI	1		Date Co	nsidered	Trong
*Examiner: In	itial if r	eference is considered, of considered, Include co	whether or not	citation is in conformance with MPEP ( with next communication to applicant.	609; Draw li	ne through	citation if not in

Suplicate

## LIST OF RELATED CASES

	Docket Number	Patent Number	Filing or Issue Date	Patent Appl.  Publication  No.	Inventor/ Applicant
A	<del>-237688US0*</del>	<del>-10/617,048</del>	<del>-7/11/03</del>	US2005- 0009989A1	LIEW, et al.
	_263326US0	<del>-11/009,088</del>	12/13/04	US2005- 0158260 A1	FERRARI, et al.
-1	_#6388-0437-0	-09/395,613	09/14/99		FERRARI
-	-272537US0PCT	10/538,920	06/13/05		BLIN, et al.
N	272535US0PCT	10/538,924	_06/13/05		et al.
-	275576US0	_11/193,444	-08/01/05		CHEN, et al.
_	264558US0PCT	10/517,390	12/10/04	·	FERRARI, et al.
-	263814US0CIP	11/024,471	12/30/04		BLIN, et al.
A	272887US0	11/217,293	09/02/05		BUI, et al.

<sup>\*</sup> Present Application; listed for information # Abandoned Application NFO/amr/hah